Stressing the Fundamentals

International Test Conference is the world’s premier conference dedicated to the electronic test of devices, boards and systems—covering the complete cycle from design verification, test, diagnosis, failure analysis and back to process and design improvement. At ITC, test and design professionals can confront the challenges the industry faces, and learn how these challenges are being addressed by the combined efforts of academia, design tool and equipment suppliers, designers, and test engineers.

ITC, the cornerstone of the Test Week™ event, offers a wide variety of technical activities targeted at test and design theoreticians and practitioners, including: formal paper sessions, tutorials, panel sessions, case studies, lecture series, commercial exhibits and presentations, and a host of ancillary professional meetings.

The 2002 conference year will focus on the simultaneous challenges of providing high-quality cost-effective tests and developing or adapting new test approaches to meet the ongoing demands of new technology. Authors are invited to submit original, unpublished papers describing recent work in the field of test and design. Submissions must include:

- Title of paper.
- Name, affiliation, mailing address, email address, telephone and fax number of each author.
- Designation of the presenter. ITC will communicate with the presenter.
- One or two topic(s) from the topic list, or a description of your topic.
- An electronic copy of a complete paper of 10 pages maximum, or an extended summary from four to six pages. Submissions of less than four pages are rarely accepted.
- An abstract of 35 words or less.

ITC maintains a highly competitive selection process for papers presented. For details of the selection process, please consult our web site. Submissions must clearly describe the status of your work, its significance and highlights. Supporting data, results and conclusions, and references to prior work must also be included. ITC does not accept submissions that do not meet all specified criteria. Please note that the submission deadline is firm.

Submission Deadline: February 22, 2002
Author Notification: May 17, 2002
Manuscript Deadline: July 3, 2002

Proposals for panels and lecture series are also welcome.

All submissions and presentations must be in electronic format. Prospective authors should read the detailed instructions regarding formats and submission requirements that are available through the ITC web site at:
http://www.itctestweek.org

Test Week Tutorial and workshop proposals are also welcomed. Deadlines and other information about making proposals can be obtained from TTTC at: http://www.computer.org/tab/tttc

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